T-46-07-11

◢◤ National
Semiconductor

74FCT574A
Octal D Flip-Flop with TRI-STATE® Outputs

General Description

The 'FCT574A is a high-speed, low power octal flip-flop with a buffered common Clock (CP) and a buffered common Output Enable ($\overline{OE}$). The information presented to the D inputs is stored in the flip-flops on the LOW-to-HIGH Clock (CP) transition.

The 'FCT574A is functionally identical to the 'FCT374A except for the pinouts.

Features

- I_{CC} and I_{OZ} reduced to 400 µA and ±2.5 µA respectively
- NSC 74FCT574A is pin and functionally equivalent to IDT74FCT574A
- Inputs and outputs on opposite sides of package allowing easy interface with microprocessors
- Useful as input or output port for microprocessors
- Functionally identical to 'FCT374A
- TRI-STATE outputs for bus-oriented applications
- 'FCT574A has TTL-compatible inputs
- I_{OL} = 48 mA
- TTL inputs accept CMOS levels

Ordering Code: See Section 8

Logic Symbols

TL/F/10150-1

IEEE/IEC
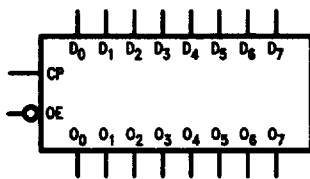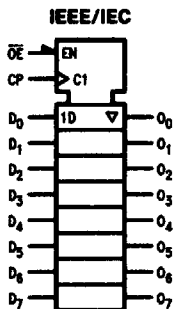
TL/F/10150-4

Connection Diagram

Pin Assignment for DIP and SOIC
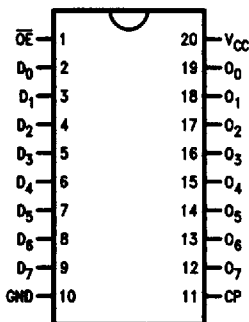
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| Pin Names	Description
D_0–D_7	Data Inputs
CP	Clock Pulse Input
$\overline{OE}$	TRI-STATE Output Enable Input
O_0–O_7	TRI-STATE Outputs

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Functional Description

The 'FCT574A consists of eight edge-triggered flip-flops with individual D-type inputs and TRI-STATE true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold time requirements on the LOW-to-HIGH Clock (CP) transition. With the Output Enable ($\overline{OE}$) LOW, the contents of the eight flip-flops are available at the outputs. When $\overline{OE}$ is HIGH, the outputs go to the high impedance state. Operation of the $\overline{OE}$ input does not affect the state of the flip-flops.

Function Table

Inputs			Internal	Outputs	Function
$\overline{OE}$	CP	D	Q	O_N	
H	H	L	NC	Z	Hold
H	H	H	NC	Z	Hold
H	╱	L	L	Z	Load
H	╱	H	H	Z	Load
L	╱	L	L	L	Data Available
L	╱	H	H	H	Data Available
L	H	L	NC	NC	No Change in Data
L	H	H	NC	NC	No Change in Data

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedance
╱ = LOW-to-HIGH Transition
NC = No Change

Logic Diagram
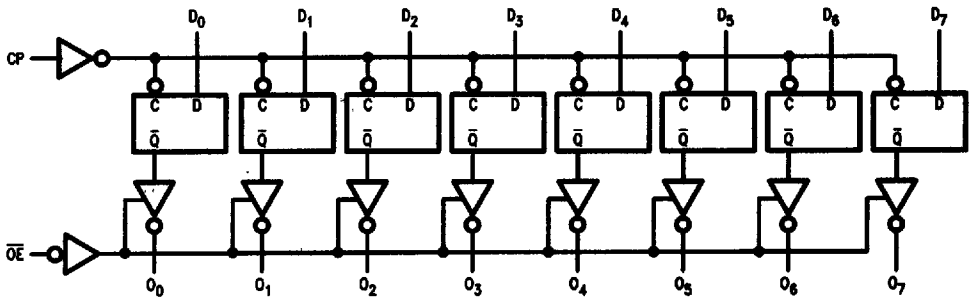
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Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Terminal Voltage with Respect to GND (V_{TERM})
74FCTA $-0.5V$ to $+7.0V$

Temperature under Bias (T_{BIAS})
74FCTA $-55°C$ to $+125°C$

Storage Temperature (T_{STG})
74FCTA $-55°C$ to $+125°C$

DC Output Current (I_{OUT})   120 mA

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT FCT circuits outside databook specifications.

Recommended Operating Conditions

Supply Voltage (V_{CC})
74FCTA   4.75V to 5.25V

Input Voltage   0V to V_{CC}

Output Voltage   0V to V_{CC}

Operating Temperature (T_A)
74FCTA   0°C to $+70°C$

Junction Temperature (T_J)
PDIP   140°C

Note: All commercial packaging is not recommended for applications requiring greater than 2000 temperature cycles from $-40°C$ to $+125°C$.

DC Characteristics for 'FCTA Family Devices

Typical values are at $V_{CC} = 5.0V$, 25°C ambient and maximum loading. For test conditions shown as Max, use the value specified for the appropriate device type: Com: $V_{CC} = 5.0V$ $\pm5\%$, $T_A = 0°C$ to $+70°C$; $V_{HC} = V_{CC} - 0.2V$.

Symbol	Parameter	74FCTA			Units	Conditions	
		Min	Typ	Max			
V_{IH}	Minimum High Level Input Voltage	2.0			V		
V_{IL}	Maximum Low Level Input Voltage			0.8	V		
I_{IH}	Input High Current			5.0 5.0	μA	$V_{CC} = $ Max	$V_I = V_{CC}$ $V_I = 2.7V$ (Note 2)
I_{IL}	Input Low Current			-5.0 -5.0	μA	$V_{CC} = $ Max	$V_I = 0.5V$ (Note 2) $V_I = $ GND
I_{OZ}	Maximum TRI-STATE Current			2.5 2.5 -2.5 -2.5	μA	$V_{CC} = $ Max	$V_O = V_{CC}$ $V_O = 2.7V$ (Note 2) $V_O = 0.5V$ (Note 2) $V_O = $ GND
V_{IK}	Clamp Diode Voltage		-0.7	-1.2	V	$V_{CC} = $ Min; $I_N = -18$ mA	
I_{OS}	Short Circuit Current	-60	-120		mA	$V_{CC} = $ Max (Note 1); $V_O = $ GND	
V_{OH}	Minimum High Level Output Voltage	2.8 V_{HC} 2.4	3.0 V_{CC} 4.3		V	$V_{CC} = 3V$; $V_{IN} = 0.2V$ or V_{HC}; $I_{OH} = -32$ μA $V_{CC} = $ Min $V_{IN} = V_{IH}$ or V_{IL}	 $I_{OH} = -300$ μA $I_{OH} = -15$ mA
V_{OL}	Maximum Low Level Output Voltage		GND GND 0.3	0.2 0.2 0.5	V	$V_{CC} = 3V$; $V_{IN} = 0.2V$ or V_{HC}; $I_{OL} = 300$ μA $V_{CC} = $ Min $V_{IN} = V_{IH}$ or V_{IL}	 $I_{OL} = 300$ μA $I_{OL} = 48$ mA

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DC Characteristics for 'FCTA Family Devices

Typical values are at V_{CC} = 5.0V, 25°C ambient and maximum loading. For test conditions shown as Max, use the value specified for the appropriate device type: Com: V_{CC} = 5.0V ±5%, T_A = 0°C to +70°C; V_{HC} = V_{CC} − 0.2V.

Symbol	Parameter	74FCTA			Units	Conditions	
		Min	Typ	Max			
I_{CC}	Maximum Quiescent Supply Current		1.0	40.0	μA	V_{CC} = Max. $V_{IN} \geq V_{HC}$, $V_{IN} \leq 0.2V$ f_I = 0	
ΔI_{CC}	Quiescent Supply Current; TTL Inputs HIGH		0.5	2.0	mA	V_{CC} = Max V_{IN} = 3.4V (Note 3)	
I_{CCD}	Dynamic Power Supply Current (Note 4)		0.15	0.25	mA/MHz	V_{CC} = Max Outputs Open $\overline{OE}$ = GND One Input Toggling 50% Duty Cycle	$V_{IN} \geq V_{HC}$ $V_{IN} \leq 0.2V$
I_C	Total Power Supply Current (Note 6)		1.5	4.0		V_{CC} = Max Outputs Open $\overline{OE}$ = GND	$V_{IN} \geq V_{HC}$ $V_{IN} \leq 0.2V$
			1.8	6.0		f_{CP} = 10 MHz f_I = 5.0 MHz One Bit Toggling 50% Duty Cycle	V_{IN} = 3.4V V_{IN} = GND
			3.0	7.8	mA	(Note 5) V_{CC} = Max Outputs Open $\overline{OE}$ = GND	$V_{IN} \geq V_{HC}$ $V_{IN} \leq 0.2V$
			5.0	16.8		f_{CP} = 10 MHz f_I = 2.5 MHz Eight Bits Toggling 50% Duty Cycle	V_{IN} = 3.4V V_{IN} = GND
V_H	Input Hysteresis on Clock Only		200		mV		

Note 1: Maximum test duration not to exceed one second, not more than one output shorted at one time.

Note 2: This parameter guaranteed but not tested.

Note 3: Per TTL driven input (V_{IN} = 3.4V); all other inputs at V_{CC} or GND.

Note 4: This parameter is not directly testable, but is derived for use in Total Power Supply calculations.

Note 5: Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed but not tested.

Note 6: I_C = $I_{QUIESCENT}$ + I_{INPUTS} + $I_{DYNAMIC}$

I_C = I_{CC} + ΔI_{CC} $D_H N_T$ + I_{CCD} ($f_{CP}/2$ + $f_I N_I$)

I_{CC} = Quiescent Current

ΔI_{CC} = Power Supply Current for a TTL High Input (V_{IN} = 3.4V)

D_H = Duty Cycle for TTL inputs High

N_T = Number of Inputs at D_H

I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)

f_{CP} = Clock Frequency for Register Devices (Zero for Non-Register Devices)

f_I = Input Frequency

N_I = Number of Inputs at f_I

All currents are in milliamps and all frequencies are in megahertz.

AC Electrical Characteristics: See Section 2 for Waveforms

Symbol	Parameter	74FCTA $T_A = +25°C$ $V_{CC} = 5.0V$	74FCTA $T_A, V_{CC} = Com$ $R_L = 500\Omega$ $C_L = 50$ pF		Units	Fig. No.
		Typ	Min	Max		
t_{PLH} t_{PHL}	Propagation Delay CP to O_n	4.5	2.0	6.5	ns	2-8
t_{PZH} t_{PZL}	Output Enable Time	5.5	1.5	6.5	ns	2-11
t_{PHZ} t_{PLZ}	Output Disable Time	4.0	1.5	5.5	ns	2-11
t_{SU}	Set-Up Time High or Low D_n to CP	1.0	2.0		ns	2-10
t_H	Hold Time High or Low D_n to CP	0.5	1.5		ns	2-10
t_W	CP Pulse Width High or Low	4.0	5.0		ns	2-9

Note 1: Minimum limits are guaranteed but not tested on propagation delays.

Capacitance $(T_A = +25°C, f = 1.0$ MHz)

Symbol	Parameter (Note 1)	Typ	Max	Units	Conditions
C_{IN}	Input Capacitance	6	10	pF	$V_{IN} = 0V$
C_{OUT}	Output Capacitance	8	12	pF	$V_{OUT} = 0V$

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